

**POWER MOSFETs**

SiHP12N50C, SiHB12N50C, SiHF12N50C

**MOSFETs - 500 V with Max  $R_{DS(on)}$  of 0.555  $\Omega$  at  $V_{GS} = 10$  V****High-Voltage MOSFETs - 500 V N-Channel Power MOSFETs  
in TO-220AB, TO-220 FULLPAK, and D<sup>2</sup>PAK Packages****KEY BENEFITS**

- Maximum  $R_{DS(on)}$  of 0.555  $\Omega$  at  $V_{GS} = 10$  V
- Low gate charge,  $Q_g$  max = 48 nC
- $R_{DS(on)} * Q_g$  FOM of 26.64  $\Omega$ -nC
- 100 % avalanche tested
- Improved  $T_{rr} / Q_{rr}$

**APPLICATIONS**

- Lighting
- Welding
- NB adapters

**RESOURCES**

- Datasheet: SiP12N50C, SiB12N50C, SiF12N50C - <http://www.vishay.com/doc?91388>
- More featured products: <http://www.vishay.com/ref/featuredmosfets>
- For technical questions contact [hvm@vishay.com](mailto:hvm@vishay.com)
- Material categorization: For definitions of compliance please see <http://www.vishay.com/doc?99912>

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# POWER MOSFETs

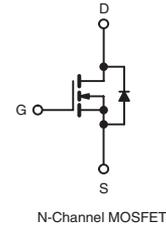
## SiHP12N50C, SiHB12N50C, SiHF12N50C



MOSFETs - 500 V with Max Rds(on) of 0.555 Ω at Vgs = 10 V

### High-Voltage MOSFETs - 500 V N-Channel Power MOSFETs in TO-220AB, TO-220 FULLPAK, and D<sup>2</sup>PAK Packages

PRODUCT SUMMARY	
V <sub>DS</sub> (V) at T <sub>J</sub> max.	560 V
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V 0.555
Q <sub>g</sub> (Max.) (nC)	48
Q <sub>gs</sub> (nC)	12
Q <sub>gd</sub> (nC)	15
Configuration	Single



ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub> = 25 °C, unless otherwise noted)				
PARAMETER	SYMBOL	LIMIT		UNIT
		TO220-AB D <sup>2</sup> PAK (TO-263)	TO-220 FULLPAK	
Drain-Source Voltage	V <sub>DS</sub>	500		V
Gate-Source Voltage	V <sub>GS</sub>	± 30		
Continuous Drain Current (T <sub>J</sub> = 150 °C) <sup>a</sup>	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	12	A
		T <sub>C</sub> = 100 °C	7.5	
Pulsed Drain Current <sup>c</sup>	I <sub>DM</sub>	28		
Linear Derating Factor		1.67	0.28	W/°C
Single Pulse Avalanche Energy <sup>b</sup>	E <sub>AS</sub>	180		mJ
Maximum Power Dissipation	P <sub>D</sub>	208	36	W
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150		°C
Soldering Recommendations (Peak Temperature) <sup>d</sup>	for 10 s	300		

**Note**  
a. Limited by maximum junction temperature.  
b. V<sub>dd</sub> = 50 V, starting T<sub>J</sub> = 25 °C, L = 2.5 mH, R<sub>g</sub> = 25 Ω, I<sub>AS</sub> = 12 A.  
c. Repetitive rating; pulse width limited by maximum junction temperature.  
d. 1.6 mm from case.

THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TO220-AB D <sup>2</sup> PAK (TO-263)	TO-220 FULLPAK	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	62	65	°C/W
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	0.6	3.5	
Junction-to-Ambient (PCB mount) <sup>a</sup>	R <sub>thJA</sub>	40	-	

**Note**  
a. When mounted on 1" square PCB (FR-4 or G-10 material).

SPECIFICATIONS (T <sub>J</sub> = 25 °C, unless otherwise noted)						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static						
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	500	-	-	V
V <sub>DS</sub> Temperature Coefficient	ΔV <sub>DS</sub> /T <sub>J</sub>	Reference to 25 °C, I <sub>D</sub> = 1 mA	-	0.6	-	V/°C
Gate-Source Threshold Voltage (N)	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	3.0	-	5.0	V
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>GS</sub> = ± 30 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V	-	-	50	μA
		V <sub>DS</sub> = 400 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	250	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 4 A	-	0.46	0.555	Ω
Forward Transconductance	g <sub>fs</sub>	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 3 A	-	3	-	S
Dynamic						
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 25 V, f = 1.0 MHz	-	1375	-	pF
Output Capacitance	C <sub>oss</sub>		-	165	-	
Reverse Transfer Capacitance	C <sub>rss</sub>		-	17	-	
Total Gate Charge	Q <sub>g</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 A, V <sub>DS</sub> = 400 V	-	32	48	nC
Gate-Source Charge	Q <sub>gs</sub>		-	12	-	
Gate-Drain Charge	Q <sub>gd</sub>		-	15	-	
Turn-On Delay Time	t <sub>d(on)</sub>		-	18	-	
Rise Time	t <sub>r</sub>	V <sub>DD</sub> = 250 V, I <sub>D</sub> = 10 A, R <sub>g</sub> = 4.3 Ω, V <sub>GS</sub> = 10 V	-	35	-	ns
Turn-Off Delay Time	t <sub>d(off)</sub>		-	23	-	
Fall Time	t <sub>f</sub>		-	6	-	
Gate Input Resistance	R <sub>g</sub>	f = 1 MHz, open drain	-	1.1	-	Ω
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode	-	-	12	A
Pulsed Diode Forward Current	I <sub>SM</sub>		-	-	28	
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 10 A, V <sub>GS</sub> = 0 V	-	-	1.8	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = I <sub>S</sub> , dI/dt = 100 A/μs, V <sub>R</sub> = 20 V	-	580	-	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>		-	4.3	-	μC
Body Diode Reverse Recovery Current	I <sub>RRM</sub>		-	13	-	A

**Note**  
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